Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/677,393	CHANG ET AL.
Examiner	**Art Unit**
Jean W. Désir	2622

SEARCHED			
Class	Subclass	Date	Examiner
348	554 555 556	2/1/2008	JWD
	558		
	537		
	581		
	739		
345	55, 81		
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	99, 100		
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345	175, 165		
	166, 173		
	204, 698		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	2/1/2008	JWD